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ABSTRACT
Vacuum ultraviolet (VUV) light at 118 nm has been shown to be a powerful tool to ionize molecules for various gas-phase chemical studies. A convenient tabletop source of 118 nm light can be produced by frequency tripling 355 nm light from a Nd:YAG laser in xenon gas. This process has a low efficiency, typically producing only 1 nJ/pulse of VUV light. Simple models of the tripling process predict that the power of 118 nm light produced should increase quadratically with increasing xenon pressure. However, experimental 118 nm production has been observed to reach a maximum and then decrease to zero with increasing xenon pressure. Here, we describe the basic theory and experimental setup for producing 118 nm light and a new proposed model for the mechanism limiting the production based on pressure broadened absorption.

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I. INTRODUCTION

Vacuum ultraviolet (VUV; \( \lambda \approx 100 \text{ nm–200 nm} \)) light sources1-7 have important applications in a wide variety of experiments in atomic physics and physical chemistry, including molecular spectroscopy for the understanding of chemical bonds,8-10 high resolution studies for metrology,11-14 and as a universal ionization source in mass spectrometry.15-17 High fluxes of VUV light are available from synchrotrons, but the complexity, cost, and beam-time constraints of these sources make a more accessible tabletop VUV source desirable. With the exception of excimer lasers18 which operate at only a few set wavelengths, tabletop sources of VUV light require the use of nonlinear optical techniques. Nonlinear optical frequency mixing,14-16 of which harmonic generation is a special case, is a powerful technique for producing coherent radiation at wavelengths where small commercial laser sources do not typically operate.19

One such VUV source is made by frequency tripling the third-harmonic output of a Nd:YAG laser in a xenon-argon gas mixture to create 118 nm light. The 118 nm photon can be used in single or multi-photon ionization applications. Specifically, chemical dynamics studies use 118 nm light in ion-pair photodissociation spectroscopy,14 ion pair production,19 anion photoelectron spectroscopy,20 and one-photon ionization processes.21-24 Additionally, 118 nm photons have been used to perform multi-photon ionization of cold radical molecules.25-27

Since the conversion efficiency to VUV light is low (\( \approx 10^{-3} \)) and may constrain the detection sensitivity of an experiment, it is important to understand the limits of the tripling technique in order to experimentally optimize 118 nm light production. The basic theory of 118 nm generation in a xenon-argon gas cell19-21 and experimental setup and challenges22-25 have been detailed in previous papers. However, the experimentally observed 118 nm photon production has been observed to significantly diverge from theory at high gas pressures and has not been modeled so far.

Here, we describe the basic theory and experimental setup for generating 118 nm light and characterize the limitation of the VUV production at high xenon pressures. We propose absorption at 118 nm by xenon as the mechanism that limits 118 nm production. We develop a model that accounts for this absorption, whose predictions are in good agreement with our experimental results.
II. THEORY OF NON-RESONANT THIRD-HARMONIC GENERATION

Anisotropic crystals with large second-order nonlinear optical susceptibilities ($\chi^{(2)}$) and a wide optical transparency range can be efficient at producing visible, near-infrared, and soft UV light. Since these crystals start to absorb light below 200 nm, generation of VUV light via nonlinear optical frequency mixing generally requires a gaseous nonlinear medium, which is transparent at these wavelengths. However, the structural symmetry of isotropic media such as gases means that only odd-order nonlinear susceptibilities are non-vanishing, leaving the third-order susceptibility, $\chi^{(3)}$, as the first nonlinear term.\(^\text{14}\)

Third-harmonic light produced by the large $\chi^{(3)}$ in these systems can extend into the VUV and extreme ultraviolet regions of the spectrum. For this process to be efficient, phase matching is important as the fundamental light and third-harmonic light must maintain a fixed phase relationship in order to coherently build the tripled light. In the gaseous system discussed here, phase matching is accomplished by mixing a negatively dispersive gas that acts as the nonlinear medium with positively dispersive gas that can be used to tune the phase matching. In the remainder of this section, we discuss the basic model of third-harmonic generation (THG) and conditions to optimize phase matching.

The basic setup for THG is depicted in Fig. 1. The fundamental light at 355 nm is focused into a gas cell of length, $L$, with a beam waist of $w_0$ and a confocal parameter of $b = \frac{2\omega_0^2}{\lambda}$. The third-harmonic light is shown in blue. The total power of the third-harmonic light produced by a focused Gaussian beam with incident fundamental power $P_\omega$ is given by\(^\text{10,31}\)

$$P_\omega = \frac{8.215 \times 10^{-2}}{(3\lambda)^3} |\chi_{\text{eff}}^{(3)}| |P_\omega| |F_1(b\Delta k)|^2. \quad (1)$$

Here, all powers are in watts, $\lambda$ is the third-harmonic wavelength in nm, and $\chi_{\text{eff}}^{(3)}$ is the macroscopic nonlinear coefficient. $F_1(b\Delta k)$ is a dimensionless function that describes phase matching, and $\Delta k$ is the wave-vector mismatch between the fundamental and third-harmonic light. $\Delta k$ is the term responsible for phase matching, and optimizing it improves the efficiency of the THG process.

Experimentally, there are three parameters that can be varied to optimize the third-harmonic power [Eq. (1)]: (1) maximizing the macroscopic nonlinear coefficient $\chi_{\text{eff}}^{(3)}$, (2) maximizing $F_1(b\Delta k)$ by optimizing phase matching, and (3) maximizing the power in the fundamental ($P_\omega$). However, as shown below, independent maximization of the first two parameters in a single gas is impossible because both $\chi_{\text{eff}}^{(3)}$ and $F_1(b\Delta k)$ are dependent on $\mathcal{N}$, the atomic number density of the gas. $\chi_{\text{eff}}^{(3)}$ is given by

$$\chi_{\text{eff}}^{(3)} = \mathcal{N} \chi_a^{(3)}, \quad (2)$$

where $\mathcal{N}$ is in units of atoms/cm$^3$ and $\chi_a^{(3)}$ is the third-order nonlinear coefficient per atom in esu. Generally, $F_1(b\Delta k)$ must be evaluated numerically. However, in the tight-focusing limit, where the nonlinear medium is much longer than the confocal parameter of the focused fundamental beam ($b \ll L$), $F_1(b\Delta k)$ can be solved analytically to give\(^\text{10,31}\)

$$|F_1(b\Delta k)|^2 = \begin{cases} \pi^2 (b\Delta k)^2 e^{b\Delta k}, & \Delta k < 0, \\ 0, & \Delta k \geq 0, \end{cases} \quad (3)$$

which has a maximum at $b\Delta k_{\text{max}} = \frac{1}{2}$.

$\Delta k$ is related to $\mathcal{N}$ through the index of refraction and is given by

$$\Delta k = \frac{2\pi}{\lambda} [n_1 - n_3]. \quad (4)$$

In this notation, $n_1$ and $n_3$ are the index of refraction at the third-harmonic wavelength $\lambda$ and the fundamental wavelength $3\lambda$, respectively. For a gas, the effective macroscopic index of refraction, $n$, is given by

$$n(\lambda) = 1 + \mathcal{N} \chi_a^{(1)}(\lambda), \quad (5)$$

where $\chi_a^{(1)}$ is the atomic linear susceptibility at wavelength $\lambda$. Therefore, $\Delta k$ can be expressed as

$$\Delta k = \frac{\lambda}{C}, \quad (6)$$

where $C = \frac{2\pi}{\lambda} [\chi_a^{(1)}(\lambda) - \chi_a^{(1)}(3\lambda)]$ is a constant describing the microscopic dispersive properties of the gaseous medium. $C$ can be thought of as the effective wave-vector mismatch per atom. Phase matching is adjusted by tuning $\Delta k$, and thus $F_1(b\Delta k)$, via the pressure of the gas.

As can be seen from Eq. (3), $\Delta k$ must be negative to generate third-harmonic light. This occurs only in media that exhibit negative dispersion (i.e., $n_3 > n_1$). Xenon was chosen as the nonlinear medium for THG of 118 nm because it is the only rare gas that exhibits negative dispersion at this wavelength. With only a negatively dispersive gas, $\Delta k$ and $\chi_{\text{eff}}^{(3)}$ are both dependent on $\mathcal{N}$. If a positively dispersive gas with negligible nonlinearity is added, $\Delta k$ and $\chi_{\text{eff}}^{(3)}$ can be decoupled. Argon is typically used as the positively
dispersive gas for THG of 118 nm light. For a mixture of the two gases, the total wave-vector mismatch at the nominal third-harmonic wavelength, $\lambda_0$, is given by summing over the partial pressures of each gas,

$$\Delta k(\lambda_0) = N_{Xe} C_{Xe}(\lambda_0) + N_{Ar} C_{Ar}(\lambda_0)$$

$$= N_{Xe} [C_{Xe}(\lambda_0) + R C_{Ar}(\lambda_0)].$$

(7)

where $R = \frac{N_{Ar}}{N_{Xe}}$ is the pressure ratio of the two gases. With the addition of argon, $Xe^{(3)}$ can be adjusted using $N_{Ar}$, while $\Delta k$ can be maximized using $N_{Xe}$.

Since $F_2/(b \Delta k)$ is maximized when $\Delta k(\lambda_0)_{max} = -\frac{2}{b}$, phase matching is optimized when the pressure ratio is

$$R_{opt} = \frac{1}{b \cdot N_{Xe} C_{Xe}(\lambda_0) / C_{Ar}(\lambda_0)}.$$  

(8)

For large xenon pressures, which are desirable for increasing $Xe^{(3)}$ and thus $P_{THG}$, the optimum ratio approaches the constant value of $\frac{C_{Ar}}{C_{Xe}}$ and is independent of the value of the confocal parameter, $b$. Using the values $C_{Ar}(118.2 \text{ nm}) = -6.12 \times 10^{-17} \text{ cm}^2$ and $C_{Xe}(118.2 \text{ nm}) = +5.33 \times 10^{-18} \text{ cm}^2$ from the work of Mahon et al., this ratio is 11.48.

III. EXPERIMENTAL SETUP FOR THIRD-HARMONIC GENERATION

The experimental apparatus used to generate VUV light is shown in Fig. 2. Light at 355 nm is produced by using a Q-switched Nd:YAG laser (Continuum: Innite III-10, internally tripled) with a repetition rate of 10 Hz and pulse duration of 7 ns. The spectral width at 355 nm is 1 cm$^{-1}$. For all of the data below, a pulse energy of 17 mJ/pulse was used. The 1 cm diameter beam is focused into a mixture of xenon and argon contained in a stainless steel cell using a 50 cm focal length lens. The gas cell is made of standard 304-SS conflat vacuum parts with an overall length of ~40 cm. A UV fused silica window seals the input end of the cell, where the 355 nm light enters. The output end, between the gas cell and the UHV detection chamber, is sealed using a 25 cm focal length MgF$_2$ lens, which also serves to focus the VUV light into the detection region.

The focal length of the lens and size of the cell must be chosen to avoid burning optics and maximize gas conductance. The cell is three standard conflat cross sections connected together and has a length of ~40 cm. The focal length of the 50 cm lens, external to the cell, was chosen to be approximately the length of the gas cell. The focus is designed to be in the center of the gas cell so that the 355 nm intensity at the input window and output lens is low enough to prevent damaging the optics. The position of the focus also allows for perpendicular optical access through a conflat window into the focal region. Although LiF windows have a higher transmission at 118 nm, a MgF$_2$ window was chosen for the output lens due to its hardness and because it is not hygroscopic, allowing the window to handle pressure differentials in excess of 1 atm. The large positive dispersion in MgF$_2$ causes the focal length of the lens at 118 nm to be about 58% shorter than that at 355 nm. This property is exploited to minimize the intensity of 355 nm in the detection region by defocusing the 355 nm light, which helps to prevent multi-photon processes. Additionally, most of the defocused 355 nm light is blocked from even reaching the detection region by a macor iris placed after the MgF$_2$ lens.

The gas cell is constructed from 2-3/4 in. conflat pieces to provide adequate gas conductance. Attempts at making portions of the gas cell out of 1/4 in. ID tubing led to trapped pockets of unmixed xenon, which slowly diffused out over several days. The release of trapped xenon led to drifts in the gas ratio, changing the phase matching and leading to drifts in the amount of 118 nm light produced.

Xenon and argon are introduced into the gas cell through a leak valve and needle valve. The needle valve is important for separating the gas mixing cell from the low conductance elements such as the pressure gauges and gas lines connecting the leak valve. Leaving open the needle valve between the gas mixing cell and the leak valve increases the gas mixing time by a factor of 3.

Gas mixing in the cell can be aided by a turbine, which causes gas to flow in a loop of 2-3/4 in. conflat pieces (Fig. 2). Gas mixing using the turbine did not reach equilibrium noticeably faster than without the turbine, but the 118 nm flux varied more smoothly while mixing. Without the turbine, adding argon to the system would cause large spikes and dips in the measured 118 flux, as the introduction of argon rapidly changed the Xe:Ar ratio in the tripling region. Unaided mixing in the cell took only 15 min with no signs of continued mixing or signal loss observed over the course of several weeks.

The 118 nm light is detected indirectly by using it to ionize deuterated ammonia (ND$_3$) and subsequently detecting ND$_3^+$. 118 nm light is focused by using the MgF$_2$ lens between two
electrodes in the UHV chamber. Ionized ND$_3$ is accelerated through a time-of-flight mass spectrometer (TOF-MS) and is detected by using a micro-channel plate (MCP) (Fig. 2). The number of ND$_3^-$ ions produced is proportional to the number of 118 nm photons that are focused into the detection region since the ionization is a one-photon process and no saturation effects are observed.

IV. PHASE MATCHING AND CONVERSION EFFICIENCY LIMITATIONS

To experimentally determine the phase matched ratio of partial pressures of Xe/Ar, we add a set amount of xenon to the mixing cell and then add increments of argon in order to map out each phase-matching curve. Figure 3 shows phase-matching curves for several xenon pressures. Each phase-matching curve was fit to Eq. (3) to extract the location of the peak 118 nm flux and the optimum Xe/Ar ratio for a given xenon pressure. The optimum Xe/Ar ratios are plotted in Fig. 4 along with a fit to Eq. (8), which gives $b = 2.3 \pm 0.3$ cm. As shown in Eq. (8), the optimum Xe/Ar ratio depends on the confocal parameter and xenon pressure, but for high xenon pressures, the ratio approaches the asymptotic limit of 11.48 (horizontal dashed line).

Although the optimum pressure ratios are consistent with the model, the conversion efficiency of 355 nm light to 118 nm does not agree with model predictions. Equation (4) predicts that for a phase-matched mixture, the 118 nm light produced should scale as the square of the xenon pressure. However, mixtures with more than 24 Torr of xenon (290 Torr total pressure) yielded decreasing 118 nm light with increasing xenon pressure. At xenon pressures $>70$ Torr, almost no 118 nm light was detected. This same turnover in 118 nm light production vs total pressure has been observed in the work of Shi et al. In other studies, optimal conversion efficiencies have been observed at lower total pressures of 20 Torr, 50 Torr, and 200 Torr. The prevalence of optimal conversion efficiencies at low total pressures and the large discrepancy between the predicted and measured yield of 118 nm light at high pressures indicate that some process, which is not included in the models, is significantly limiting the production of 118 nm light.

The deviation from theory for the expected 118 nm flux of a phase-matched mixture of Xe/Ar at higher total pressures is accompanied by the appearance of a fluorescence streak inside the gas cell (inset Fig. 5). It appears near the focus of the 355 nm light and along the propagation axis. The fluorescence streak does not appear when 355 nm light is focused into the cell filled with only argon or only xenon. Instead it appears only when xenon and argon are both present and near a phase-matched ratio. The fluorescence is collected through a vacuum window using a lens outside the gas.
cell to focus the light onto a photodiode. The fluorescence intensity follows the shape of the generated VUV light flux throughout a phase-matching curve, as shown in Fig. 5, indicating that 118 nm photons play a role in the fluorescence. Figure 6 shows the 118 nm flux and fluorescence signal as a function of the xenon pressure for a phase-matched mixture. The fluorescence appears to begin at some threshold xenon pressure and increases roughly linearly in intensity with increasing xenon pressure.

118 nm light was also created using krypton as the phase-matching gas. Using the same apparatus and measurements described above, xenon and krypton were phase matched with an optimum Kr/Xe ratio of 4.6, which agreed with the krypton dispersion calculated in Ref. 34. This mixture also produced a maximum of 118 nm light followed by a decrease with increasing gas pressure. The fluorescence streak was also present only with a phase-matched mixture of the two gases (Fig. 6).

Spectra of the fluorescence were obtained for the Xe/Ar [Fig. 7(a)] and Xe/Kr [Fig. 7(b)] systems using an Ocean Optics USB2000 spectrometer. Spectral lines were assigned using data from the NIST Atomic Spectra Database.35 We mark the location of all lines in the NIST database that are above a certain threshold relative intensity35 in order to identify observed lines and note which lines are missing from the spectra. For Xe and Kr, a threshold of 0.001 was used, and for Ar, a threshold of 0.001 relative intensity was used. The Xe/Ar spectrum [Fig. 7(a)] shows predominantly Xe I spectral lines and weak Ar I spectral lines. The lines are similar in relative signal to those observed from a xenon arc lamp, indicating that the fluorescence is likely from electron-ion recombination in xenon. The spectrum for the Xe/Kr system [Fig. 7(b)] also shows predominantly Xe I spectral lines, with Kr I spectral lines appearing relatively weakly. Xenon is ionized preferentially despite being present in a lower concentration than the phase-matching gases (Ar or Kr). This would seem to indicate that ionization is not due to just the high electric field of the 355 nm light but also due to a resonant process involving xenon.

The energetics suggests that a two-photon process is causing the ionization of xenon. The energy of a single 118 nm photon (10.5 eV) is below the ionization potential of xenon (12.1 eV). However, the combined energy of one 118 nm photon and one 355 nm photon (14 eV) is enough to ionize xenon, while being below the ionization potential of argon (15.8 eV). The ionization potential of krypton (14 eV) is low enough to possibly be ionized in this system; however, strong ionization of krypton is not evident. Two-photon ionization of xenon, where one of the photons is 118 nm and the other is a 355 nm photon, is likely the mechanism producing xenon ions. The intensity of the 355 nm light is much larger than that of the third harmonic, so we can assume that the absorption of the 118 nm light is the rate limiting step. We model this process as two-photon, two-color ionization model where the absorption of the 118 nm photon is far from resonance and is affected by the pressure in the gas.
cell due to pressure broadening. This pressure broadened absorption is the proposed mechanism for loss of 118 nm light in the detection region for high cell pressures. In xenon, the two lines closest to resonance with the 118 nm light are the Xe (2P1/2) 5d [3/2] line at 119.2 nm and the Xe (2P3/2) 7s line at 117 nm. We also must consider the Kr (2P1/2) 5d [1/2] resonance line at 116.5 nm, which can lead to additional absorption in the case of phase matching with Kr. Argon does not have any transitions near enough to 118 nm to cause significant loss.

V. ABSORPTION CROSS SECTION

We consider far off-resonance absorption in the presence of pressure broadening. The atomic absorption cross section for light at frequency $\omega$ due to an absorption line at $\omega_0$ is given by

$$\sigma(\omega) = \frac{f e^2}{m e_0 \epsilon_0} \left(\frac{\gamma}{2}\right)^2 \left(\frac{\omega - \omega_0}{\gamma} + \frac{\gamma}{2}\right)^2,$$

where $f$ is the oscillator strength, $e$ is the electron charge, $m$ is the mass of the electron, $e_0$ is the permittivity of free space, $\epsilon$ is the speed of light, and $\gamma$ is the linewidth. Far from resonance, $(\omega - \omega_0)^2 \gg (\gamma/2)^2$, and Eq. (9) can be approximated as

$$\sigma(\omega) = \frac{f e^2}{4 m e_0 \epsilon_0} \frac{\gamma}{(\omega - \omega_0)^2},$$

noting that the cross section is proportional to the linewidth.

For gases at high pressures, collisions between atoms contribute to the Lorentzian linewidth of an absorption in a process known as pressure broadening. Neutral atoms undergoing collisions induce a dipole that perturbs the energy levels and broadens the linewidth of transitions. Collisions between atoms of the same species experience resonant collisions that enhance this broadening. Same-species broadening is typically ~1 GHz × 2π per Torr of gas vs ~10 MHz × 2π per Torr of gas for collisions between different species. In our two-species gas, although the phase matching gas is present in much higher quantities than xenon, resonant Xe–Xe collisional broadening will dominate the pressure broadening. The pressure broadened linewidth is given by

$$\gamma = \gamma_n + \gamma_c,$$

where $\gamma_n$ is the natural linewidth and $\gamma_c$ is the collisional linewidth, which is proportional to the density, $\gamma_c = \beta N$, where $\beta$ is the collisional broadening coefficient and $N$ is the density of the gas. For the lines considered in this paper, $\gamma_n \approx 100$ MHz × 2π per Torr, while $\gamma_c \sim 1$ GHz × 2π per Torr of gas. Hence, for pressures used in this experiment, $\gamma_n \ll \gamma_c$, and $\gamma_c$ can be ignored such that $\gamma \approx \gamma_c$. This allows us to write our pressure broadened cross section as

$$\sigma(\omega) = \frac{f e^2}{4 m e_0 \epsilon_0} \frac{\beta N}{(\omega - \omega_0)^2} = a N,$$

where $a$ is defined as our pressure broadening constant.

VI. SIMULATION RESULTS

In order to compare our pressure broadened absorption model to the experimental data, we simulate the simultaneous tripling and absorption processes in our gas system. The electric field of an electromagnetic wave with frequency, $\omega$, and wavenumber, $k$, propagating along the $z$ axis is given by

$$E(z, t) = A e^{i(kz - \omega t)} + c.c.$$

where $A$ is the electric field amplitude. The intensity of the electric field is related to the electric field amplitude by $I = 2n e_0 |A|^2$. The change in the intensity of the 118 nm beam as it propagates through a medium can be simulated by calculating the change in the electric field amplitude. The differential equation describing the propagation of the 118 nm beam is given by

$$\frac{d|A_{118}|}{dz} = \frac{1}{2} \chi^{(3)} N_{Xe} k_{118} |A_{355}|^3 - \frac{1}{2} \chi^{(3)} N_{Xe} k_{118} |A_{118}|,$$

where $\chi^{(3)}$ is the third-order susceptibility, $N_{Xe}$ is the density of xenon, $k_{118}$ is the wavenumber of the 118 nm light, $A_{355}$ is the field amplitude of the 355 nm beam, $\sigma$ is the absorption cross section, and $A_{118}$ is the field amplitude of the 118 nm beam. This term describes the third-harmonic generation of 118 nm light assuming perfect phase matching, and the second term describes the loss of 118 nm light due to absorption. Using Eq. (12), this becomes

$$\frac{d|A_{118}|}{dz} = \frac{1}{2} \chi^{(3)} N_{Xe} k_{118} |A_{355}|^3 - \frac{1}{2} \chi^{(3)} N_{Xe} k_{118} |A_{118}|,$$

The 355 nm power is kept constant, assuming that the third-harmonic generation leads to negligible loss. To account for the fact that the 355 nm beam is focusing through the gas cell, the electric field amplitude along the $z$ axis is scaled by the radius of the beam,

$$|A_{355}(z)| = |A_{355}(0)| \frac{\omega_0}{\omega(z)},$$

where $\omega_0$ is the beam waist, $\omega(z) = \omega_0 \sqrt{1 + (z/\alpha R)^2}$ is the beam radius as a function of $z$, and $A_{355}(0)$ is the field amplitude at the focus calculated from the experimental parameters.

Although the 118 nm beam also has a transverse spread that changes through the focus, the 118 nm amplitude is not scaled by the beam radius. This assumes that the effects of the transverse spread are negligible on relative measurements across our parameter space. The majority of the third-harmonic generation takes place within the Rayleigh range, where the beam radius varies from $\omega_0 - \sqrt{2}\omega_0$. We assume that this variation is negligible and the 118 nm light is created with roughly the same beam radius. Linear absorption does not affect the width of a Gaussian beam, thus, the transverse expansion of the beam is the same for all parameters, and ignoring the expansion does not effect relative measurements.

The differential equation is numerically integrated over the 40 cm length of the gas cell, with the focus at the center. The 118 nm field amplitude at the end is used to calculate a beam flux since our experimental results are a measure of the flux of the 118 nm photons. Additionally, we assume that the amount of light from the fluorescence streak is proportional to the loss of 118 nm light in a region around the focus of the 355 nm beam that approximates our fluorescence collection region.

Using our simulations, we want to model the experiment shown in Fig. 6 and then compare the simulated and experimental results to extract a value for $\alpha$. The two free parameters in this simulation are the pressure-broadening constant, $\alpha$, and an overall
vertical scaling of the magnitude of the signal. For a single value of \( \alpha \), the simulation is run for a range of xenon pressures to produce a curve of 118 nm flux vs pressure similar to Fig. 6. The simulated curves are fit to the experimental data by calculating a sum of squared residuals between the experimental and simulated results for a given value of \( \alpha \) and vertical scaling factor.

The fitted simulation results for the Xe/Ar case are shown in Fig. 8. The model accurately reproduces the shape of the experimental 118 nm flux. A value of \( \alpha_{Xe} = 0.84(1) \times 10^{-37} \text{ cm}^4 \) is extracted from the fit, where the error bar represents only the statistical uncertainty in the fit. We can compare this value of \( \alpha_{Xe} \) to the one calculated using an oscillator strength \( f = 0.379 \) from Ref. 39 and a collisional broadening coefficient \( \beta = 5.6 \text{ GHz/Torr} \) extracted from the experimental data in Ref. 38. The two lines in xenon nearest to the 118 nm light are the Xe \((^3P_{1/2})5d \left[ \frac{5}{2} \right] \) line at 119.2 nm and the Xe \((^3P_{3/2})7s \) line at 117 nm. The contribution due to the 117 nm line is negligible since the oscillator strength is a factor of 4 smaller and the collisional line width is a factor of 5 smaller than the 119.2 nm line. The expected value of \( \alpha_{Xe} \) is calculated to be \( 1.18 \times 10^{-37} \text{ cm}^4 \), in reasonable agreement with our experimentally determined fit value considering the simple model used.

In the case of phase matching with krypton, the Kr \((^3P_{1/2})5d \left[ \frac{1}{2} \right] \) resonance line at 116.5 nm also leads to absorption of 118 nm light. This can be accounted for with an additional loss term of

\[
\left( \frac{d |A_{118}|}{dz} \right)_{Kr} = -\frac{1}{2} \alpha_{Kr} N_{Kr} |A_{118}|, \tag{17}
\]

where \( \alpha_{Kr} \) is the pressure broadening coefficient due to krypton and \( N_{Kr} \) is the density of krypton. Since the density of xenon and krypton are related by the phase matching ratio, Eq. (15) can be rewritten as

\[
\frac{d |A_{118}|}{dz} = \frac{1}{2} \chi^{(3)} N_{KoKo} |A_{355}|^3 - \frac{1}{2} \alpha_{Kr/Ko} N_{Kr} |A_{118}|, \tag{18}
\]

where \( \alpha_{Kr/Ko} = \alpha_{Kr} + \alpha_{Ko} R^2 \). The results of this model are fit to the experimental Kr results in Fig. 9, with the model reproducing the shape of the experimental curve. From the fit, a value of \( \alpha_{Kr} = 4.6(2) \times 10^{-39} \text{ cm}^4 \) can be compared to an expected value of \( \alpha_{Kr} = 7.1 \times 10^{-39} \text{ cm}^4 \) calculated using an oscillator strength \( f = 0.193 \) from Ref. 39 and a collisional broadening coefficient \( \beta = 3.0 \text{ GHz/Torr} \) extracted from the experimental data in Ref. 38.

For both Xe/Ar and Xe/Kr, the fluorescence results from the model do not match the experimental results well. However, there is some qualitative agreement. The fluorescence appears to turn on near the pressure where the 118 nm flux starts to turn over. The experimental fluorescence appears to increase linearly, while the simulated results appear to increase non-linearly. This may be attributed to uncertainties in the fluorescence measurement. The fluorescence streak is several cm long and extends beyond the window through which we have optical access to collect fluorescence. We collect only a small portion of the fluorescence streak around the focus.

VII. DISCUSSION AND CONCLUSIONS

Absorption by dimers was also considered as a mechanism for loss. Hüblig and Wallenstein attributed loss of Lyman-alpha radiation (121.56 nm) to absorption by Xe2 and XeKr dimers. Absorption lines have been observed from Xe2 molecules in the region between the Xe \((^3P_{1/2})5d \left[ \frac{5}{2} \right] \) line at 119.2 nm and 118.6 nm. However, the contribution of absorption due to these dimers is estimated to be only a few percent of the measured absorption. Furthermore, dimer absorption would not explain the difference in the absorption of VUV light observed between phase matching with Ar vs Kr. The presence of XeAr absorption lines between 119.2 nm and 118.6 nm and the relative lack of XeKr lines would predict greater absorption in a mixture of Xe and Ar, while we observe the opposite. Therefore,
we predict any effect from dimers on the observed absorption to be small.

A 118 nm light source could be optimized by considering design options that limit the amount of absorption. Minimizing the amount of xenon, the 118 nm light must pass through will increase the yield. This can be accomplished by shortening the gas cell and tightening the focus, but the damage threshold of optical components must be considered. Another option might be using a jet of gas rather than a gas cell. While third-harmonic generation has been studied in a pulsed supersonic jet of pure xenon, jets of phase matched mixtures have not yet been studied. The use of a jet could possibly enhance VUV production and reduce phase-matching requirements due to the small interaction region.

Finally, it might be possible to improve the VUV output by shifting the light to a slightly shorter wavelength. There is a local minimum in the absorption cross section between the 5d and 7s lines at around 117.5 nm that is a factor of 3 less than the cross section at 118.2 nm. However, the change in the third-harmonic generation efficiency will need to be considered due to the change in the refractive index as the wavelength approaches the 7s line.

Third harmonic generation of 118 nm light in a Xe/Ar gas cell is a widely used top source of VUV radiation. The yield of 118 nm light has been observed to diverge from simple theoretical predictions. The observation of ionized xenon at the focus of the 355 nm beam in the presence of 118 nm light suggests that two-photon ionization, led by absorption of 118 nm light, is the mechanism limiting the amount of 118 nm light that excites the gas cell. To confirm this mechanism, we developed a model based on pressure broadened absorption that can be modeled using a simple 1D simulation. The simulated results are fit to experimental data to extract a pressure-broadening constant, which agrees with the values calculated from theory.

These results provide a comprehensive understanding of a widely used light source and are expected to contribute significantly to robust VUV light production in chemical physics experiments.

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DATA AVAILABILITY

The data that support the findings of this study are available from the corresponding author upon reasonable request.

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